

<b>Notice of References Cited</b>	Application/Control No. 10/571,075		Applicant(s)/Patent Under Reexamination ALBARRAN MOYO ET AL.	
	Examiner Khanh B. Pham		Art Unit 2166	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,035,308 A	03-2000	Yano et al.	715/201
*	B	US-5,477,012 A	12-1995	Sekendur, Oral F.	178/18.09
*	C	US-6,014,668 A	01-2000	Tabata et al.	707/10
*	D	US-6,076,734 A	06-2000	Dougherty et al.	235/462.01
*	E	US-6,081,261 A	06-2000	Wolff et al.	345/179
*	F	US-6,330,976 B1	12-2001	Dymetman et al.	235/487
*	G	US-6,502,756 B1	01-2003	F.ang.hraeus, Christer	235/494
*	H	US-6,356,923 B1	03-2002	Yano et al.	717/127
*	I	US-7,623,713	11-2009	Lapstun et al.	382/187
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.